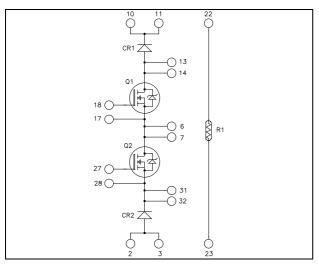
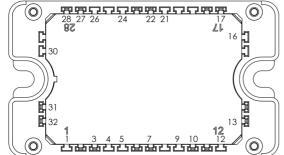


# Boost buck chopper MOSFET Power Module

$$\begin{split} V_{DSS} &= 600V \\ R_{DSon} &= 24 m\Omega \ max \ @ \ Tj = 25^{\circ}C \\ I_D &= 95A \ @ \ Tc = 25^{\circ}C \end{split}$$





All multiple inputs and outputs must be shorted together Example: 10/11; 13/14; 6/7 ...

#### **Application**

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

#### **Features**

- CoolMOS<sup>TM</sup>
  - Ultra low R<sub>DSon</sub>
  - Low Miller capacitance
  - Ultra low gate charge
  - Avalanche energy rated
  - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

#### Absolute maximum ratings (per CoolMOS)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		600	V
T	Continuous Drain Current $T_c = 25^{\circ}$	$T_c = 25^{\circ}C$	95	
$I_{D}$	Continuous Diani Current	$T_c = 80$ °C	70	A
$I_{DM}$	Pulsed Drain current		260	
$V_{GS}$	Gate - Source Voltage		±20	V
R <sub>DSon</sub>	Drain - Source ON Resistance		24	mΩ
$P_{D}$	Maximum Power Dissipation $T_c = 25^{\circ}C$		462	W
$I_{AR}$	Avalanche current (repetitive and non repetitive)		15	A
$E_{AR}$	Repetitive Avalanche Energy		3	mJ
$E_{AS}$	Single Pulse Avalanche Energy		1900	1113

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### All ratings @ $T_i = 25$ °C unless otherwise specified

### Electrical Characteristics (per CoolMOS)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 25^{\circ}C$			350	μА
		$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 125^{\circ}C$			600	
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 47.5A$			24	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 5mA$	2.1	3	3.9	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			200	nA

### **Dynamic Characteristics** (per CoolMOS)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 25V$		14.4		nF
$C_{oss}$	Output Capacitance	f = 1MHz		17		111
$Q_{g}$	Total gate Charge	$V_{GS} = 10V$		300		Ì
$Q_{gs}$	Gate – Source Charge	$V_{\text{Bus}} = 300 \text{V}$		68		nC
$Q_{\mathrm{gd}}$	Gate – Drain Charge	$I_D = 95A$		102		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		21		
$T_{\rm r}$	Rise Time	$V_{GS} = 10V$		30		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{D}} = 95A$		100		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 2.5\Omega$		45		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		1350		μJ
E <sub>off</sub>	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 400V$ $I_D = 95A ; R_G = 2.5\Omega$		1040		μυ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		2200		ī
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 400V$ $I_D = 95A ; R_G = 2.5\Omega$		1270		μJ

### Chopper diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V
$I_{RM}$	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_j = 25$ °C			500	пΔ
1 <sub>RM</sub>		V R−000 V	$T_{j} = 125^{\circ}C$			1000	μA
$I_{\mathrm{F}}$	DC Forward Current		$Tc = 80^{\circ}C$		120		A
	Diode Forward Voltage	$I_F = 120A$	$T_j = 25$ °C		1.6	1.8	
$V_{\rm F}$		$I_{\rm F} = 240 A$			1.9		V
		$I_{\rm F} = 120A$	$T_i = 125$ °C		1.4		
+	Reverse Recovery Time		$T_j = 25$ °C		130		ne
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 120A$ $V_R = 400V$	$T_j = 125$ °C		170		ns
Qrr	Reverse Recovery Charge	$di/dt = 400A/\mu s \qquad T_j = 2$	$T_j = 25$ °C		440		nC
<b>V</b> rr			$T_j = 125$ °C		1840		пс

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### Thermal and package characteristics

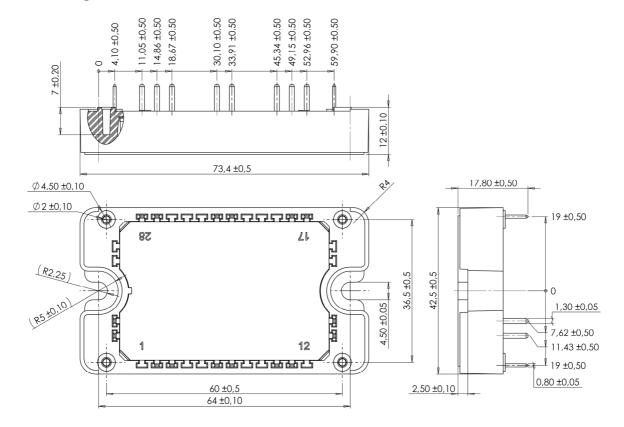
Symbol	Characteristic			Min	Тур	Max	Unit
$R_{\text{thJC}}$	Junction to Case Thermal Resistance		Per CoolMOS			0.27	°C/W
			Per diode			0.46	C/W
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz			4000			V
$T_{J}$	Operating junction temperature range			-40		150	
$T_{STG}$	Storage Temperature Range			-40		125	°C
$T_{\rm C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					110	g

### **Temperature sensor NTC**

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
$\Delta R_{25}/R_{25}$	Resistance tolerance			5	%
$\Delta \mathrm{B/B}$	Beta tolerance			3	/0
B <sub>25/100</sub>	$T_{25} = 298.16 \text{ K}$		3980		K

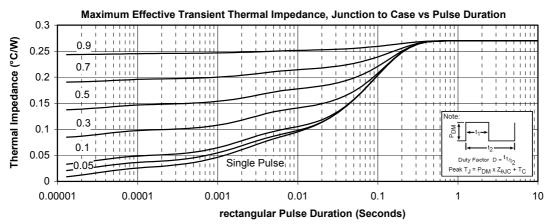
$$R_T = \frac{R_{25}}{\exp \left[ B_{25/100} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

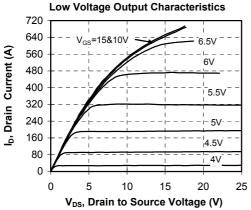
### SP3F Package outline (dimensions in mm)

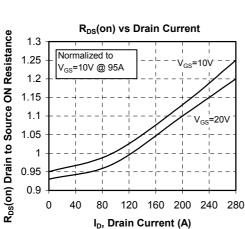


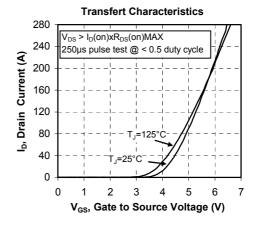


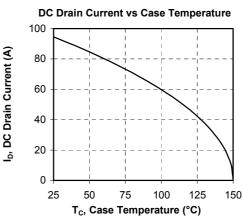
#### **Typical CoolMOS Performance Curve**



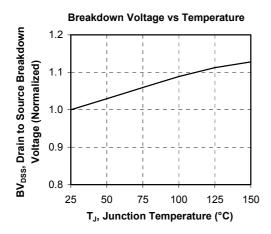


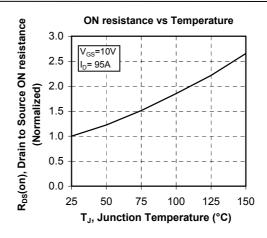


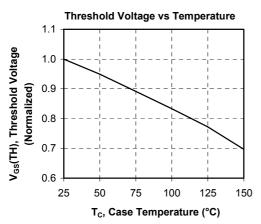


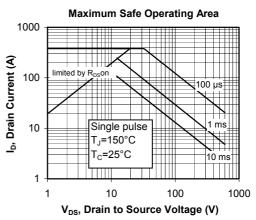


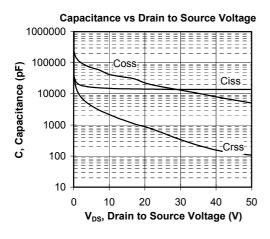


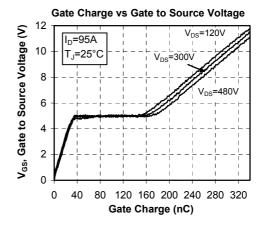




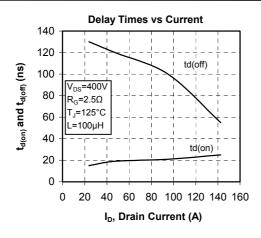


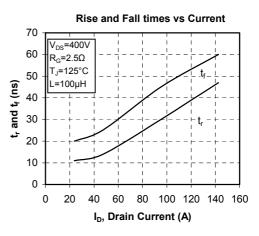


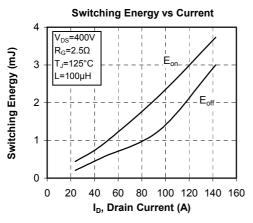


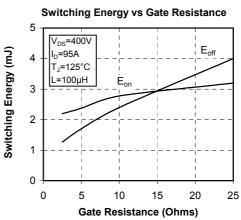


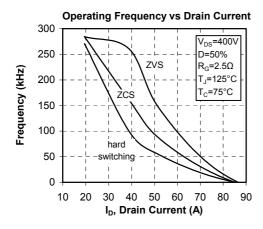


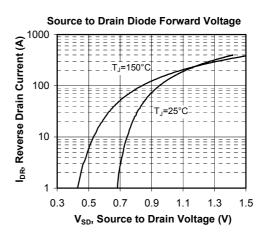






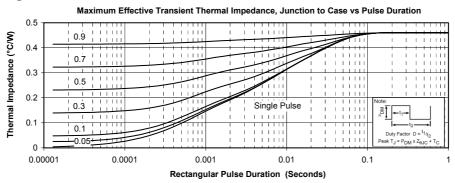


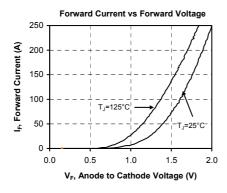


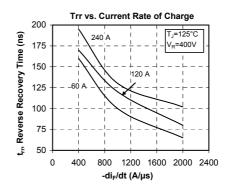


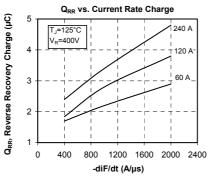


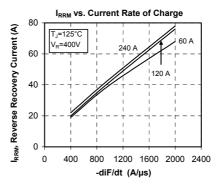
### Typical diode performance curves

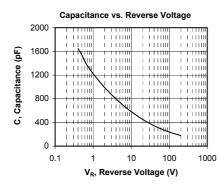












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